Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/539,693	HAACKE ET AL.	
Examiner	Art Unit	
Joseph L. Williams	2879	

,	SEAR	CHED		
Class	Subclass	Date	Examiner	
313	568 570 573 572 634 637	1/4/2007	JW	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u> </u>				

SI (INCLUDIN	ARCH NOTE S SEARCH S	ES STRATEGY)
		DATE	EXMR
None		1/7/2007	JW